
Form 1449 (Modified)
**Information Disclosure
Statement By Applicant**

(Use Several Sheets if Necessary)

Atty Docket No:	U.S.
ROXIP262	09/378,398
Applicants:	
TEO, Patrick	
Filing Date:	Group:
August 20, 1999	2613

U.S. Patent Documents

Examiner Initial	No.	Patent No.	Date	Patentee	Class	Sub-class
A						
B						
C						
D						
E						
F					JUN 11 2003	
G						
H					Technology Center 2600	
I						
J						
K						

RECEIVED

JUN 11 2003

Technology Center 2600

Foreign Patent or Published Foreign Patent Application

Examiner Initial	No.	Document No.	Publication Date	Country or Patent Office	Class	Sub-class	Translation	
							Yes	No
L								
M								
N								
O								
P								

Other Documents

Examiner Initial	No.	Author, Title, Date, Place (e.g. Journal) of Publication
an	Q	“Round Shot Model Super 35”, Seitz, 4 pp., 1997.
an	R	“Casio QV700 Digital Camera & DP-8000 Digital Photo Printer”, Joe Farace, 3 pp., 11-6-97.
an	S	“Round Shot”, 4pp.
an	T	“Casio QV-200, QV-700”, James Karney, PC Magazine, 2pp., 2-10-98.
an	U	“Round Shot Super 35 13.5.96”. Bob Erickson, 1 pg.
an	V	“Casio Adds New Camera To Its Lineup”, Kelly Ryer, MacWeek, Vol. 11, issue 38, 1 pg., October 2, 1997.

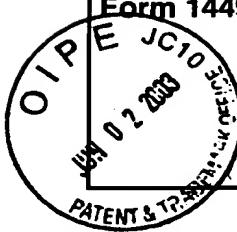
Examiner

ET Ge

Date Considered

11/17/03

Examiner: Initial citation considered. Draw line through citation if not in conformance and not considered.
 Include copy of this form with next communication to applicant.


Form 1449 (Modified)
**Information Disclosure
Statement By Applicant**

(Use Several Sheets if Necessary)

Attorney Docket No:

U.S.
09/378/398

Applicant: TEO, Patrick

Filing Date:

Group: 2613

August 20, 1999

U.S. Patent Documents

Examiner Initial	No.	Patent No.	Date	Patentee	Class	Sub-class	Filing Date
	A	US 4 763 280		Robinson et al.			
	B	US 4 811 245		Bunker et al.			
	C	US 4 841 292		Zeno			RECEIVED
	D	US 5 022 085		Cok			
	E	US 5 138 460		Egawa			JUN 03 2003
	F	US 5 155 586		Levy et al.			
	G	US 5 175 808		Sayre			TECHNOLOGY CENTER R3700
	H	US 5 185 808		Cok			
	I	US 5 231 385		Gengler et al.			
	J	US 5 251 022		Kitamura			
	K	US 5 262 867		Kojima			
	L	US 5 307 451		Clark			
	M	US 5 325 449		Burt et al.			
	N	US 5 338 200		Olive			
	O	US 5 396 583		Chen et al.			
	P	US 5 420 533		Kelley et al. Park			
	Q	US 5 412 764		Tanaka			
	R	US 5 424 773		Saito			
	S	US 5 442 738		Chapman et al.			
	T	US 5 444 478		LeLong et al.			
	U	US 5 446 833		Miller et al.			
	V	US 5 488 674		Burt et al.			
	W	US 5 528 290		Saund			
	X	US 5 544 283		Kaufman et al.			
	Y	US 5 550 959		Freeman			
	Z	US 5 550 960		Shirman et al.			
	AA	US 5 586 232		Yoshida			
	BB	US 5 561 756		Miller et al.			
	CC	US 5 574 836		Broemmelsiek			
	DD	US 5 577 176		Friedman et al.			
	EE	US 5 579 456		Cosman			
	FF	US 5 583 975		Naka et al.			
	GG	US 5 586 231		Florent et al.			
✓	HH	US 5 586 246		Nobori et al.			
✓	II	US 5 590 250		Lamping et al.			

Page 1 of 2

CC Ca
Examiner

11/17/03

Date Considered



Examiner Initial	No.	Patent No.	Date	Patentee	Class	Sub-class	Filing Date
an	JJ	US 5 594 676		Greggain et al.			
	KK	US 5 594 843		O'Neill			
	LL	US 5 594 844		Sakai et al.			
	MM	US 5 594 845		Florent et al.			
	NN	US 5 608 850		Robertson			
	OO	US 5 613 048		Chen et al.			
	PP	US 5 630 037		Schindler			JUN 03 2003
	QQ	US 5 646 679		Yano et al.			TECHNOLOGY CENTER R3700
	RR	US 5 649 032		Burt et al.			
	SS	US 5 650 814		Florent et al.			
	TT	US 5 748 194		Chen			
an	UU	US 5 963 213		Guedalia et al.			

RECEIVED

Foreign Patent or Published Foreign Patent Application

Examiner Initial	No.	Document No.	Publication Date	Country or Patent Office	Class	Sub- class	Translation	
							Yes	No
	L							
	M							
	N							
	O							
	P							

Other Documents

Examiner Initial	No.	Author, Title, Date, Place (e.g. Journal) of Publication
	R	
	S	
	T	
Examiner		Date Considered

Examiner: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.